

IRFSL3806-VB Datasheet Power MOSFET

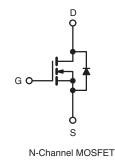
PRODUCT SUMMARY				
V _{DS} (V)	60			
R _{DS(on)} (Ω)	$V_{GS} = 10 V$ 0.015			
Q _g (Max.) (nC)	110			
Q _{gs} (nC)	29			
Q _{gd} (nC)	36			
Configuration	Single			

FEATURES

- Advanced process technology
- 175 °C operating temperature
- · Fast switching







= 25 °C, uni	less otherwis	se noted)			
PARAMETER			LIMIT	UNIT	
		V _{DS}	60	v	
		V _{GS}	± 20	v	
V at 10 V	T _C = 25 °C	1	60		
VGS AL TO V	T _C = 100 °C	١D	50	А	
Pulsed Drain Current ^{a, e}			290		
Linear Derating Factor			1.3	W/°C	
		E _{AS}	100	mJ	
Maximum Power Dissipation $T_{C} = 25 \text{ °C}$		D	190	w	
T _A =	25 °C	PD	3.7	vv	
		dV/dt	4.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	- °C	
for	10 s		300		
	V_{GS} at 10 V $T_C = T_A = $ e	$V_{GS} \text{ at } 10 \text{ V} \qquad \frac{T_C = 25 \text{ °C}}{T_C = 100 \text{ °C}}$ $T_C = 25 \text{ °C}$ $T_A = 25 \text{ °C}$	$\begin{tabular}{ c c c c c c } \hline V_{GS} & & V_{GS} \\ \hline V_{GS} \mbox{ at 10 V } & \hline T_C = 25 \ ^{\circ}C & & I_D \\ \hline & & & I_{DM} \\ \hline & & & & \\ \hline & & & & \\ \hline & & & & \\ \hline & & & &$	$\begin{tabular}{ c c c c c } \hline $YMBOL$ $LIMIT$ \\ V_{DS} & 60 \\ V_{GS} & \pm20$ \\ \hline $T_C = 25\ ^{\circ}C$ I_D & 60 \\ \hline $T_C = 100\ ^{\circ}C$ & I_D & 60 \\ \hline $T_C = 100\ ^{\circ}C$ & I_D & 50 \\ \hline I_D & 290 \\ \hline I_S & 100 \\ \hline I_S & 100 \\ \hline $I_C = 25\ ^{\circ}C$ P_D & 190 \\ \hline $T_A = 25\ ^{\circ}C$ & P_D & 190 \\ \hline $T_A = 25\ ^{\circ}C$ & P_D & 3.7 \\ \hline dV/dt & 4.5 \\ \hline e & $T_J, T_{stg} & -55 to +175$ \\ \hline \end{tabular}$	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 25 \text{ V}$, Starting $T_J = 25 \text{ °C}$, $L = 22 \mu$ H, $R_g = 25 \Omega$, $I_{AS} = 72 \text{ A}$ (see fig. 12). c. $I_{SD} \le 72 \text{ A}$, dl/dt $\le 200 \text{ A/}\mu$ s, $V_{DD} \le V_{DS}$, $T_J \le 175 \text{ °C}$. d. 1.6 mm from case. e. Uses IRFZ48, SiHFZ48 data and test conditions.

f. Calculated continuous current based on maximum allowable junction temperature.



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB mount) ^a	R _{thJA}	-	40	°C / W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.8			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS}	= 0, I _D = 250 μA	60	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA ^c	-	0.060	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	1.5	-	3.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$	-	-	± 100	nA
Zara Cata Valtaga Drain Current	1	V _{DS}	= 60 V, V _{GS} = 0 V	-	-	25	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 48 V	, V _{GS} = 0 V, T _J = 150 °C	-	-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$	I _D = 15 A ^b	-	0.015	-	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 25 V, I _D = 15 A ^b	27	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$		-	3500	-	pF
Output Capacitance	C _{oss}		$V_{DS} = 25 V,$		1300	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5 ^c		-	190	-	
Total Gate Charge	Qg			-	-	110	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$V_{GS} = 10 V$ $I_D = 12 A, V_{DS} = 48 V,$ see fig. 6 and 13 ^{b, c}		-	29	nC
Gate-Drain Charge	Q _{gd}		see lig. o and to	-	-	36	-
Turn-On Delay Time	t _{d(on)}			-	8.1	-	
Rise Time	t _r	V_{DD} = 30 V, I _D = 12 A, R _g = 9.1 Ω , R _D = 0.34 Ω , see fig. 10 ^{b, c}		-	250	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	210	-	
Fall Time	t _f			-	250	-	
Internal Source Inductance	L _S	Between lead, and center of die contact		-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	50 ^c	
Pulsed Diode Forward Current ^a	I _{SM}	p - n junction diode		-	-	90	A
Body Diode Voltage	V_{SD}	T _J = 25 °C	, I _S = 72 A, V _{GS} = 0 V ^b	-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 00 1	70 4 -11/-14 - 400 4/ - 6 0	-	120	180	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_{\rm J} = 25$ °C, $I_{\rm F} =$	= 72 A, dl/dt = 100 A/µs ^{b, c}	-	500	800	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	rn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %. c. Uses VBL1615/IRFSL3806-VB data and test conditions.

d. Calculated continuous current based on maximum allowable junction temperature.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

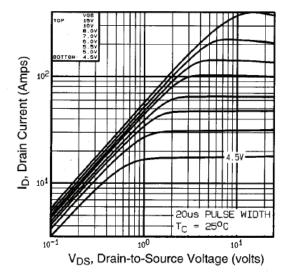


Fig. 1 - Typical Output Characteristics

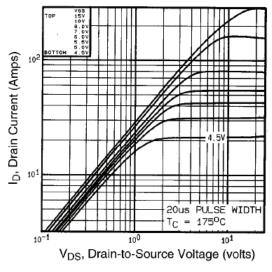


Fig. 2 - Typical Output Characteristics

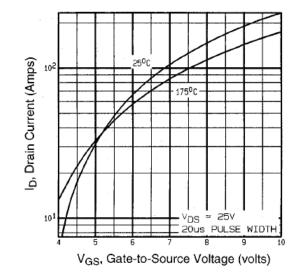


Fig. 3 - Typical Transfer Characteristics

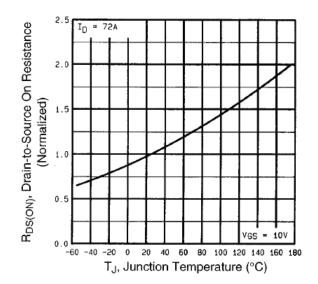


Fig. 4 - Normalized On-Resistance vs. Temperature

IRFSL3806-VB

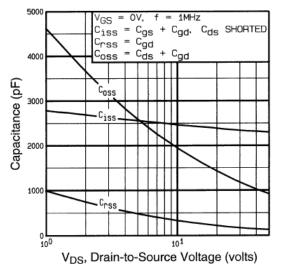


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

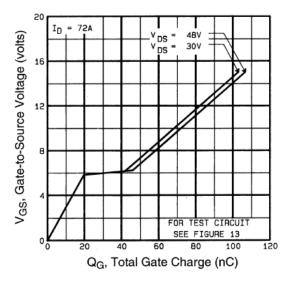
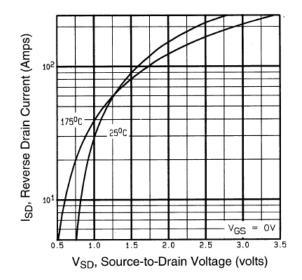


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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Fig. 7 - Typical Source-Drain Diode Forward Voltage

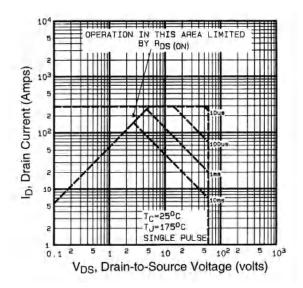


Fig. 8 - Maximum Safe Operating Area



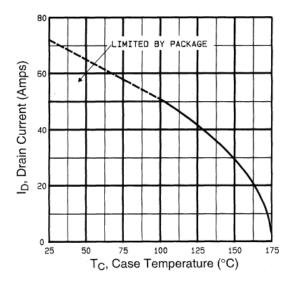


Fig. 9 - Maximum Drain Current vs. Case Temperature

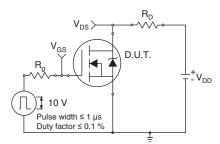


Fig. 10a - Switching Time Test Circuit

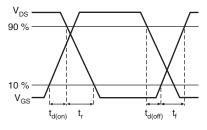
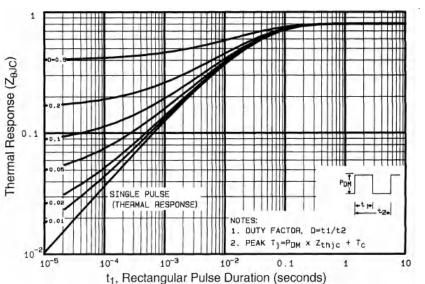
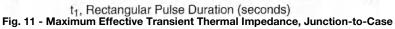


Fig. 10b - Switching Time Waveform





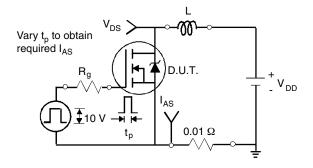


Fig. 12a - Unclamped Inductive Test Circuit

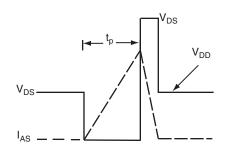


Fig. 12b - Unclamped Inductive Waveforms



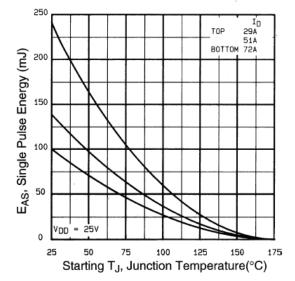


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

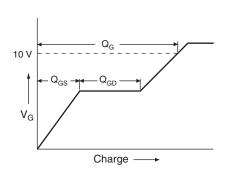


Fig. 13a - Maximum Avalanche Energy vs. Drain Current

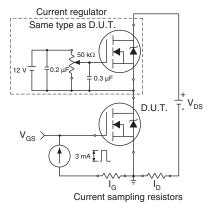
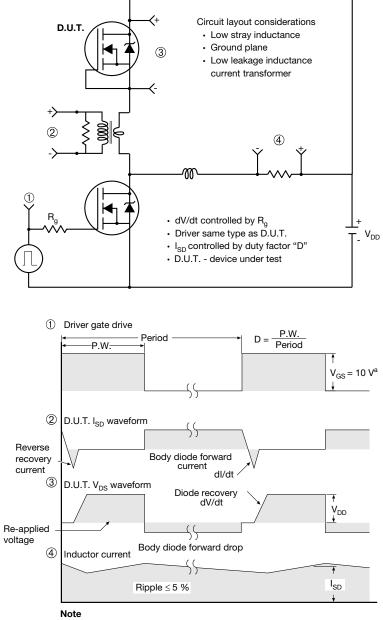


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

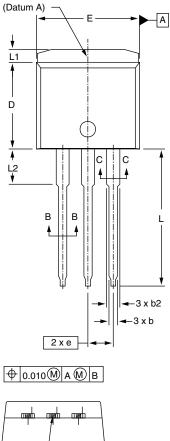


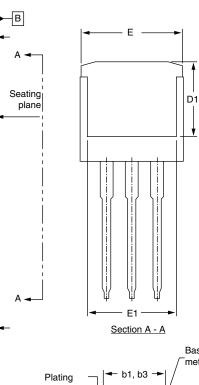
a. $V_{GS} = 5 V$ for logic level devices

Fig. 14 - For N-Channel



I²PAK (TO-262) (HIGH VOLTAGE)





Lead	tip
Louu	up

				Г	Base metal
ating	•	b1, t	o3 -	/	
¢ ¢					↑ c1
	-	(b, t	o2) —	-	

Section B - B and C - C Scale: None

	MILLIMETERS		INC	HES			
DIM.	MIN.	MAX.	MIN.	MAX.			
А	4.06	4.83	0.160	0.190			
A1	2.03	3.02	0.080	0.119			
b	0.51	0.99	0.020	0.039			
b1	0.51	0.89	0.020	0.035			
b2	1.14	1.78	0.045	0.070			
b3	1.14	1.73	0.045	0.068			
С	0.38	0.74	0.015	0.029			
c1	0.38	0.58	0.015	0.023			
c2 1.14 1.65 0.045 0.065							
	ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977						

	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
D	8.38	9.65	0.330	0.380	
D1	6.86	-	0.270	-	
Е	9.65	10.67	0.380	0.420	
E1	6.22	-	0.245	-	
е	2.54	2.54 BSC		0.100 BSC	
L	13.46	14.10	0.530	0.555	
L1	-	1.65	-	0.065	
L2	3.56	3.71	0.140	0.146	

Notes

1. Dimensioning and tolerancing per ASME Y14.5M-1994.

2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.

c → | | →

→ A1

3. Thermal pad contour optional within dimension E, L1, D1, and E1.

4. Dimension b1 and c1 apply to base metal only.



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